

FCC Radio Test Report FCC ID: SIB-SNBJR-MT5C

	This report concerns	(check one) :	Original Grant	Class II Change
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Project No. : 1406C191 Equipment : nabi Tablet

Model Name : SNBJR-MT5C; SNBJR-MT5D Applicant : Foxconn International Inc.

Address : No.2, Ziyou St., Tucheng Dist., New Taipei

City 236, Taiwan

Tested by: BTL Inc.

Date of Receipt: Jun. 24, 2014

Date of Test: Jun. 24, 2014~ Jul. 07, 2014

Issued Date: Jul. 09, 2014

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Declaration

BTL represents to the client that testing is done in accordance with standard procedures as applicable and that test instruments used has been calibrated with the standards traceable to National Measurement Laboratory (**NML**) of **R.O.C.**, or National Institute of Standards and Technology (**NIST**) of **U.S.A.**

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Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective.

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REPORT ISSUED HISTORY

Issued No.	Description	Issued Date
NEI-FCCP-1-1406C191	Original Issue.	Jul. 09, 2014

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1. CERTIFICATION

Equipment : nabi Tablet

Brand Name: nabi

Model Name: SNBJR-MT5C; SNBJR-MT5D Applicant: Foxconn International Inc.

Manufacturer: FUHU INC

Address : 909 N SEPULVEDA BLVD STE 540 EL SEGUNDO, CA 90245-2733

Date of Test : Jun. 24, 2014~ Jul. 07, 2014 Test Item : ENGINEERING SAMPLE

Standard(s) : FCC Part15, Subpart E(15.407) / ANSI C63.4 : 2009;

FCC KDB 789033 D01 General UNII Test Procedures Old Rule v01r04.

The above equipment has been tested and found compliance with the requirement of the relative standards by BTL Inc..

The test data, data evaluation, and equipment configuration contained in our test report (Ref No. NEI-FCCP-1-1406C191) were obtained utilizing the test procedures, test instruments, test sites that has been accredited by the Authority of TAF according to the ISO-17025 quality assessment standard and technical standard(s).

Test result included in this report is only for the 5150MHz~5250MHz;5250MHz~5350MHz; 5470~5725MHz Mode part of the product.

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2. SUMMARY OF TEST RESULTS

Test procedures according to the technical standard(s):

FCC Part15, Subpart E						
Standard(s) Section	Test Item	Judgment	Remark			
15.207	AC Power Line Conducted Emissions	PASS				
15.407(a)	26dB Spectrum Bandwidth	PASS				
15.407(a)	Maximum Conducted Output Power	PASS				
15.407(a)	Power Spectral Density	PASS				
15.407(a)	Radiated Emissions	PASS				
15.407(b)	Band Edge Emissions	PASS				
15.407(g)	Frequency Stability	PASS				
15.203	Antenna Requirements	PASS				

NOTE:

(1)" N/A" denotes test is not applicable in this test report

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2.1 TEST FACILITY

The test facilities used to collect the test data in this report is **DG-C02/DG-CB03** at the location of No.3, Jinshagang 1st Road, ShiXia, Dalang Town, Dong Guan, China.523792

BTL's test firm number for FCC: 319330 BTL's test firm number for IC: 4428B-1

2.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $\mathbf{y} \pm \mathbf{U}$, where expended uncertainty \mathbf{U} is based on a standard uncertainty multiplied by a coverage factor of $\mathbf{k=2}$, providing a level of confidence of approximately $\mathbf{95}\%$ \circ

A. Conducted Measurement:

Test Site	Method	Measurement Frequency Range	U, (dB)	NOTE
DG-C02	CISPR	150 KHz ~ 30MHz	1.94	

B. Radiated Measurement:

Test Site	Method	Measurement Frequency Range	Ant. H / V	U,(dB)	NOTE
		9KHz~30MHz	V	3.79	
		9KHz~30MHz	Н	3.57	
		30MHz ~ 200MHz	V	3.82	
		30MHz ~ 200MHz	Н	3.60	
DG-CB03	CISPR	200MHz ~ 1,000MHz	V	3.86	
DG-CB03	CISEIX	200MHz ~ 1,000MHz	Н	3.94	
		1GHz~18GHz	V	3.12	
		1GHz~18GHz	Н	3.68	
		18GHz~40GHz	V	4.15	
		18GHz~40GHz	Н	4.14	

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3. GENERAL INFORMATION

3.1 GENERAL DESCRIPTION OF EUT

Equipment	nabi Tablet				
Brand Name	nabi				
Model Name	SNBJR-MT5C; SNBJR-MT5D				
Mode Different	Only differ in model name and m	emory.			
	Operation Frequency	Band 1:5150MHz~5250MHz Band 2:5250MHz~5350MHz Band 3:5470MHz~5725MHz			
	Modulation Type	OFDM			
	Bit Rate of Transmitter	11a:6/ 9/12/18/24/36/48/54Mbps 11n:300Mbps			
Product Description	Output Power (Max.)- Band 1	802.11a: 14.90dBm 802.11n (20M): 13.80dBm 802.11n (40M): 13.90dBm			
	Output Power (Max.)- Band 2	802.11a: 14.90dBm 802.11n (20M): 13.80dBm 802.11n (40M): 13.90dBm			
	Output Power (Max.)- Band 3	802.11a: 14.90dBm 802.11n (20M): 13.80dBm 802.11n (40M): 13.90dBm			
	More details of EUT technical specification, please refer to the User's Manual.				
Power Source	#1 DC voltage supplied from AC adapter. Brand / Model: Chicony / W12-010N3A #2 Supplied from rechargeable Li-ion polymer battery. Brand / Model: McNair / MLP496069 #1 I/P: AC 100-240V~50/60Hz 0.3A O/P: DC 5V 2A #2 DC 3.7V 2400mAh 8.88Wh				
Power Rating					
Connecting I/O Port(s)	Please refer to the User's Manua				

Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

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2. Channel List:

802.11a / 802.11n 20M							
Ва	ınd 1	Ва	ind 2		Ban	id 3	
Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
36	5180	52	5260	100	5500	116	5580
40	5200	56	5280	104	5520	132	5660
44	5220	60	5300	108	5540	136	5680
48	5240	64	5320	112	5560	140	5700

	802.11n 40M							
Ва	Band 1 Band 2 Band 3							
Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	
38	5190	54	5270	102	5510	118	5590	
46	5230	62	5310	110	5550	126	5630	
						134	5670	

3.

Antenna Specification:

Ant.	Manufacturer	Model Name	Antenna Type	Connector	Gain (dBi)
1	JIENG TAI	AH-JT-0219N0304	PIFA	N/A	2.81

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3.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Test Mode	Description	
Mode 1	TX A Mode / CH36, CH40, CH48(Band 1) TX A Mode / CH52, CH60, CH64(Band 2) TX A Mode / CH100, CH116, CH140(Band 3)	
Mode 2	TX N20 Mode / CH36, CH40, CH48(Band 1) TX N20 Mode / CH52, CH60, CH64(Band 2) TX N20 Mode / CH100, CH116, CH140(Band 3)	
Mode 3	TX N40 Mode / CH38, CH46 (Band 1) TX N40 Mode / CH54, CH62 (Band 2) TX N40 Mode/CH102, CH110, CH134(Band 3)	
Mode 4	TX Mode	

The EUT system operated these modes were found to be the worst case during the pre-scanning test as following:

For Conducted Test		
Final Test Mode Description		
Mode 4	TX Mode	

Note: For Conducted test, the Dipole antenna with external cable is found to be the worst case and recorded.

For Radiated Test			
Final Test Mode	Description		
Mode 1	TX A Mode / CH36, CH40, CH48(Band 1) TX A Mode / CH52, CH60, CH64(Band 2) TX A Mode / CH100, CH116, CH140(Band 3)		
Mode 2	TX N20 Mode / CH36, CH40, CH48(Band 1) TX N20 Mode / CH52, CH60, CH64(Band 2) TX N20 Mode / CH100, CH116, CH140(Band 3)		
Mode 3	TX N40 Mode / CH38, CH46 (Band 1) TX N40 Mode / CH54, CH62 (Band 2) TX N40 Mode/CH102, CH110, CH134(Band 3)		

Note: For Radiated Below 1G test, the 802.11a mode is found to be the worst case and recorded.

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3.3 TABLE OF PARAMETERS OF TEXT SOFTWARE SETTING

During testing channel & power controlling software provided by the customer was used to control the operating channel as well as the output power level. The RF output power selection is for the setting of RF output power expected by the customer and is going to be fixed on the firmware of the final end product

Test software version	N/A		
Frequency	5180 MHz	5200 MHz	5240 MHz
A Mode	15.5	15.5	15.5
Frequency	5260 MHz	5300 MHz	5320 MHz
A Mode	15.5	15.5	15.5
Frequency	5500 MHz	5580 MHz	5700 MHz
A Mode	15.5	15.5	15.5

Test software version	ART		
Frequency	5180 MHz	5200 MHz	5240 MHz
N20 Mode	14	14	14
Frequency	5260 MHz	5300 MHz	5320 MHz
N20 Mode	14	14	14
Frequency	5500 MHz	5580 MHz	5700 MHz
N20 Mode	14	14	14

Test software version	ART		
Frequency	5190 MHz	5230MHz	
N40 Mode	12	15	
Frequency	5270 MHz	5310 MHz	
N40 Mode	15	11	
Frequency	5510 MHz	5550 MHz	5670 MHz
N40M Mode	14.5	14.5	14.5

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3.4 BLOCK DIAGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED

EUT	

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3.5 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	FCC ID	Series No.	Note
-	-	-	-	-	-	-

Item	Shielded Type	Ferrite Core	Length	Note
-	-	-	-	-

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4. EMC EMISSION TEST

4.1 CONDUCTED EMISSION MEASUREMENT

4.1.1 POWER LINE CONDUCTED EMISSION (Frequency Range 150KHz-30MHz)

	Class A (dBuV)		Class B (dBuV)	
FREQUENCY (MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46 *
0.50 -5.0	73.00	60.00	56.00	46.00
5.0 -30.0	73.00	60.00	60.00	50.00

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

4.1.2 TEST PROCEDURE

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item –EUT Test Photos.

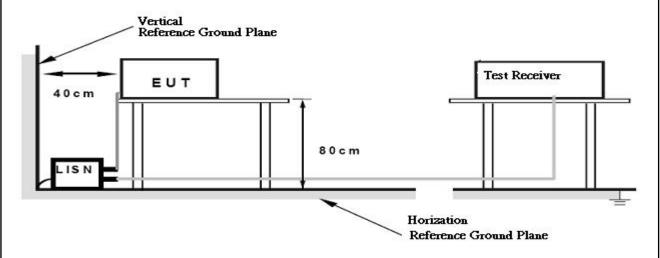
4.1.3 DEVIATION FROM TEST STANDARD

No deviation

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4.1.4 TEST SETUP



4.1.5 EUT OPERATING CONDITIONS

The EUT was configured for testing in a typical fashion (as a customer would normally use it). The EUT has been programmed to continuously transmit during test. This operating condition was tested and used to collect the included data.

The EUT was programmed to be in continuously transmitting/TX Mode mode.

4.1.6 EUT TEST CONDITIONS

Temperature: 25°C Relative Humidity: 55% Test Voltage: AC 120V/60Hz

4.1.7 TEST RESULTS

Please refer to the Attachment A.

Remark:

- (1) All readings are QP Mode value unless otherwise stated AVG in column of Note. If the QP Mode Measured value compliance with the QP Limits and lower than AVG Limits, the EUT shall be deemed to meet both QP & AVG Limits and then only QP Mode was measured, but AVG Mode didn't perform on this case, a " * " marked in AVG Mode column of Interference Voltage Measured on the Note of
- (2) Measuring frequency range from 150KHz to 30MHz o

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4.2 RADIATED EMISSION MEASUREMENT

4.2.1 RADIATED EMISSION LIMITS (Frequency Range 9kHz-1000MHz)

20dBc in any 100 kHz bandwidth outside the operating frequency band. In case the emission fall within the restricted band specified on 15.205(a) and RSS-210 section 2.2&A8.5, then the 15.209(a) and RSS-Gen limit in the table below has to be followed.

Frequencies	Field Strength	Measurement Distance
(MHz)	(micorvolts/meter)	(meters)
0.490~1.705	24000/F(KHz)	30
1.705~30.0	30	30
30~88	100	3
88~216	150	3
216~960	200	3
Above 960	500	3

Notes:

- (1) The limit for radiated test was performed according to FCC PART 15C.
- (2) The tighter limit applies at the band edges.

LIMITS OF UNWANTED EMISSION OUT OF THE RESTRICTED BANDS

Frequencies	FIDD Limit (dDm)	Equivalent Field Strength
(MHz)	EIRP Limit (dBm)	at 3m (dBµV/m)
5150~5250	-27	68.3
5250~5350	-27	68.3
5470~5725	-27	68.3
5725 · 5925	-27	68.3
5725~5825	-17	78.3

NOTE: The following formula is used to convert the equipment isotropic radiated power (eirp) to field strength:

$$E = \frac{10000000\sqrt{30P}}{3}$$
 µV/m, where P is the eirp (Watts)

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4.2.2 TEST PROCEDURE

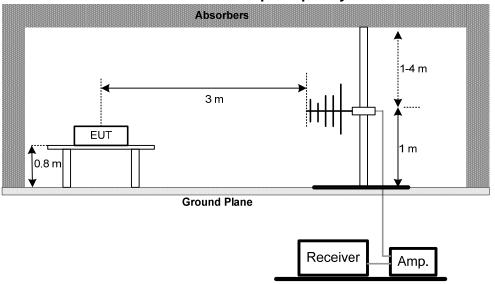
- a. The measuring distance of at 1.5m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

4.2.3 DEVIATION FROM TEST STANDARD

No deviation

4.2.4 TEST SETUP

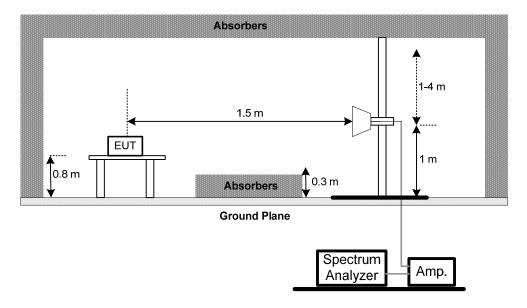
Radiated Emission Test Set-Up Frequency30 - 1000MHz



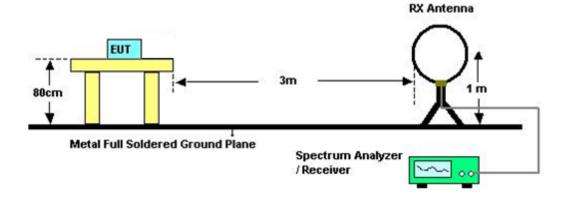
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Radiated Emission Test Set-Up Frequency Above 1 GHz



Radiated emissions below 30MHz



4.2.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **4.1.6** Unless otherwise a special operating condition is specified in the follows during the testing.

4.2.6 EUT TEST CONDITIONS

Temperature: 25°C Relative Humidity: 55% Test Voltage: AC 120V/60Hz

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4.2.7 TEST RESULTS (9K TO 30MHz)

Please refer to the Attachment B

4.2.8 TEST RESULTS (BETWEEN 30 TO 1000 MHz)

Please refer to the Attachment C.

Remark:

- (1) Reading in which marked as QP or Peak means measurements by using are Quasi-Peak Mode or Peak Mode with Detector BW=120KHz ; SPA setting in RBW=120KHz, VBW =120KHz, Swp. Time = $0.3 \text{ sec./MHz} \circ$
- (2) All readings are Peak unless otherwise stated QP in column of 『Note』. Peak denotes that the Peak reading compliance with the QP Limits and then QP Mode measurement didn't perform ∘
- (3) Measuring frequency range from 30MHz to 1000MHz •
- (4) If the peak scan value lower limit more than 20dB, then this signal data does not show in table \circ

4.2.9 TEST RESULTS (ABOVE 1000 MHz)

Please refer to the Attachment D.

Remark:

- (1) Spectrum Setting: 30MHz 1000MHz, RBW= 100KHz, VBW=100KHz, Sweep time = 200 ms. 1GHz- 40GHz, RBW= 1MHz, VBW= 1MHz, Sweep time = Auto
- (2) All readings are Peak unless otherwise stated AV in column of 『Note』. Peak denotes that the Peak reading compliance with the AV Limits and then AV Mode measurement didn't perform.
- (3) Radiated emissions measured in frequency range above 1000MHz were made with an instrument using Peak detector mode and AV detector mode of the emission ∘
- (4) Data of measurement within this frequency range shown " * " in the table above means the reading of emissions are attenuated more than 20dB below the permissible limits or the field strength is too small to be measured.
- (5) A preamp and high pass filter were used for this test in order to provide sufficient measurement sensitivity.
- (6) EUT Orthogonal Axes:
 - "X" denotes Laid on Table; "Y" denotes Vertical Stand; "Z" denotes Side Stand
- (7) During the measurements above 1GHz it is taken care of that the EUT is always within the 3dB cone of radiation BW of the used antenna.

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5. 26dB SPECTRUM BANDWIDTH

5.1 APPLIED PROCEDURES / LIMIT

FCC Part15, Subpart E			
Test Item	Limit	Frequency Range (MHz)	Result
		5150MHz~5250	
26 dB Bandwidth		5250MHz~5350	PASS
		5470MHz~5725	

5.1.1 TEST PROCEDURE

a. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram below,

h			
"			

Spectrum Parameters	Setting
Attenuation	Auto
Span Frequency	> 26dB Bandwidth
RB	300 kHz
VB	1000 kHz
Detector	Peak
Trace	Max Hold
Sweep Time	Auto

c. Measured the spectrum width with power higher than 26dB below carrier

5.1.2 DEVIATION FROM STANDARD

No deviation.

5.1.3 TEST SETUP



5.1.4 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 4.1.6 Unless otherwise a special operating condition is specified in the follows during the testing.

5.1.5 EUT TEST CONDITIONS

Temperature: 25°C Relative Humidity: 55% Test Voltage: AC 120V/60HZ

5.1.6 TEST RESULTS

Please refer to the Attachment E.

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6. MAXIMUM CONDUCTED OUTPUT POWER

6.1 APPLIED PROCEDURES / LIMIT

FCC Part15, Subpart E			
Test Item	Frequency Range (MHz)	Limit	Result
	5150 - 5250	not exceed the lesser of 50 mW (17dBm) or 4 dBm + 10log B (FCC Part15, Subpart E)	PASS
Conducted Output Power	5250 - 5350	not exceed the lesser of 250 mW (24dBm) or 11 dBm + 10log B	PASS
	5470 - 5725	not exceed the lesser of 250 mW (24dBm) or 11 dBm + 10log B	PASS

Note: where "B" is the 26 dB emissions bandwidth in MHz.

6.1.1 TEST PROCEDURE

a. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram below,

b.

Spectrum Parameter	Setting
Attenuation	Auto
Span Frequency	Encompass the entire emissions bandwidth (EBW) of the signal
RBW	= 1 MHz.
VBW	≥ 3 MHz.
Detector	RMS
Trace	Max Hold
Sweep Time	auto

b. Test was performed in accordance with method of KDB 789033 D01.

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6.1.2 DEVIATION FROM STANDARD

No deviation.

6.1.3 TEST SETUP

EUT	SPECTRUM
	ANALYZER

6.1.4 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 4.1.6 Unless otherwise a special operating condition is specified in the follows during the testing.

6.1.5 EUT TEST CONDITIONS

Temperature: 25°C Relative Humidity: 55% Test Voltage: AC 120V/60Hz

6.1.6 TEST RESULTS

Please refer to the Attachment F.

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7. ANTENNA CONDUCTED SPURIOUS EMISSION

7.1 APPLIED PROCEDURES / LIMIT

FCC Part15, Subpart E			
Test Item	Limit	Frequency Range (MHz)	Result
Antenna conducted Spurious Emission	-27 dBm/1MHz	5150 - 5250 5250 - 5350 5470 - 5725	PASS

7.1.1 TEST PROCEDURE

a. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram below,

h	
1)	
\sim	

Spectrum Parameter	Setting
Attenuation	Auto
RB	1000 kHz
VB	1000 kHz
Trace	Max Hold
Sweep Time	Auto

7.1.2 DEVIATION FROM STANDARD

No deviation.

7.1.3 TEST SETUP

EUT	SPECTRUM
	ANALYZER

7.1.4 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 4.1.6 Unless otherwise a special operating condition is specified in the follows during the testing.

7.1.5 EUT TEST CONDITIONS

Temperature: 25°C Relative Humidity: 55% Test Voltage: AC 120V/60HZ

7.1.6 TEST RESULTS

Please refer to the Attachment G.

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8. POWER SPECTRAL DENSITY TEST

8.1 APPLIED PROCEDURES / LIMIT

FCC Part15, Subpart E			
Test Item	Limit	Frequency Range (MHz)	Result
Dower Speetral	4 dBm	5150 - 5250	PASS
Power Spectral Density	11 dBm	5250 - 5350	PASS
Delisity	11 dBm	5470 - 5725	PASS

8.1.1 TEST PROCEDURE

a. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram below,

1_	
n	
v	

Spectrum Parameter	Setting
Attenuation	Auto
Span Fraguency	Encompass the entire emissions bandwidth (EBW) of
Span Frequency	the signal
RB	= 1 MHz.
VB	≥ 3 MHz.
Detector	RMS
Trace	Max Hold
Sweep Time	Auto

8.1.2 DEVIATION FROM STANDARD

No deviation.

8.1.3 TEST SETUP

EUT	SPECTRUM
	ANALYZER

8.1.4 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 4.1.6 Unless otherwise a special operating condition is specified in the follows during the testing.

8.1.5 EUT TEST CONDITIONS

Temperature: 25°C Relative Humidity: 55% Test Voltage: AC 120V/60HZ

8.1.6 TEST RESULTS

Please refer to the Attachment H.

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9. FREQUENCY STABILITY MEASUREMENT

9.1 APPLIED PROCEDURES / LIMIT

FCC Part15, Subpart E 15.407(g)						
Test Item Limit Frequency Range (MHz) Result						
Frequency Stability	specified in the user's manual	5150 – 5250	PASS			
		5250 – 5350	PASS			
		5470 – 5725	PASS			

9.1.1 TEST PROCEDURE

a. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram below,

n	
u	

Spectrum Parameter	Setting
Attenuation	Auto
Span Frequency	Entire absence of modulation emissions bandwidth
RB	10 kHz
VB	10 kHz
Sweep Time	Auto

c. The test extreme voltage is to change the primary supply voltage from 85 to 115 percent of the nominal value.

9.1.2 DEVIATION FROM STANDARD

No deviation.

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d. user manual temperature is 0°C~50°C.



9.1.3 TEST SETUP

EUT	SPECTRUM
	ANALYZER

9.1.4 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 4.1.6 Unless otherwise a special operating condition is specified in the follows during the testing.

9.1.5 EUT TEST CONDITIONS

Temperature: 25°C Relative Humidity: 55% Test Voltage: AC 120V/60HZ

9.1.6 TEST RESULTS

Please refer to the Attachment I.

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10. MEASUREMENT INSTRUMENTS LIST

	Conducted Emission Measurement						
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until		
1	LISN	EMCO	3816/2	00052765	Mar. 29, 2015		
2	LISN	R&S	ENV216	100087	Mar. 29, 2015		
3	Test Cable	N/A	C_17	N/A	Mar. 14, 2015		
4	EMI TEST RECEIVER	R&S	ESCS30	826547/022	Mar. 29, 2015		
5	50Ω Terminator	SHX	TF2-3G-A	08122902	Mar. 29, 2015		

	Radiated Emission Measurement						
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until		
1	Antenna	Schwarbeck	VULB9160	9160-3232	Mar. 29, 2015		
2	Amplifier	HP	8447D	2944A09673	Mar. 29, 2015		
3	Test Receiver	R&S	ESCI	100382	Mar. 29, 2015		
4	Test Cable	N/A	C-01_CB03	N/A	Jul. 01, 2015		
5	Antenna	ETS	3115	00075789	Mar. 29, 2015		
6	Amplifier	Agilent	8449B	3008A02274	Mar. 29, 2015		
7	Spectrum	Agilent	E4408B	US39240143	Nov. 09, 2014		
8	Test Cable	HUBER+SUHNER	C-45	N/A	Mar. 29, 2015		
9	Controller	CT	SC100	N/A	N/A		
10	Horn Antenna	EMCO	3115	9605-4803	Mar. 29, 2015		
11	Active Loop Antenna	R&S	HFH2-Z2	830749/020	Mar. 29, 2015		
12	Broad-Band Horn Antenna	Schwarzbeck	BBHA 9170	9170319	Feb. 22, 2015		

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	26dB Spectrum Bandwidth Measurement					
Ite	m	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
	1	Spectrum Analyzer	R&S	FSP 40	100185	Nov. 11, 2014

	Maximum Conducted Output Power Measurement					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	Spectrum Analyzer	R&S	FSP 40	100185	Nov. 11, 2014	

	Antenna Conducted Spurious Emission Measurement					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	Spectrum Analyzer	R&S	FSP 40	100185	Nov. 11, 2014	

	Power Spectral Density Measurement					
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until	
1	Spectrum Analyzer	R&S	FSP 40	100185	Nov. 11, 2014	

Frequency Stability Measurement											
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until						
1	Spectrum Analyzer	R&S	FSP 40	100185	Nov. 11, 2014						
2	Precision Oven Tester	HOLINK	H-T-1F-D	BA03101701	May. 25, 2014						

Remark: "N/A" denotes no model name, serial no. or calibration specified.

All calibration period of equipment list is one year.

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11. EUT TEST PHOTOS

Conducted Measurement Photos





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Radiated Measurement Photos

9KHz~30MHz





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Radiated Measurement Photos

30~1000MHz





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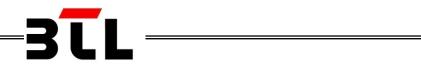
Radiated Measurement Photos

Above 1000MHz





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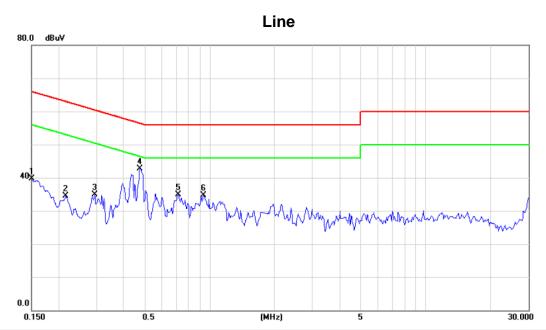


ATTACHMENT A - CONDUCTED EMISSION

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Test Mode : TX MODE



No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	0.1500	30.14	9.52	39.66	66.00	-26.34	peak	
2	0.2164	24.97	9.55	34.52	62.96	-28.44	peak	
3	0.2945	25.28	9.59	34.87	60.40	-25.53	peak	
4 *	0.4781	33.04	9.69	42.73	56.37	-13.64	peak	
5	0.7164	25.22	9.62	34.84	56.00	-21.16	peak	
6	0.9391	24.95	9.69	34.64	56.00	-21.36	peak	

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Test Mode : TX MODE

No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBu∨	dB	Detector	Comment
1	0.1734	28.46	9.62	38.08	64.80	-26.72	peak	
2	0.3063	25.65	9.62	35.27	60.07	-24.80	peak	
3	0.4156	28.76	9.63	38.39	57.54	-19.15	peak	
4	0.4781	32.76	9.64	42.40	56.37	-13.97	peak	
5	0.8375	26.79	9.67	36.46	56.00	-19.54	peak	
6 *	13.5586	37.52	10.23	47.75	60.00	-12.25	peak	

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ATTACHMENT B - RADIATED EMISSION (9KHZ TO 30MHZ)

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Test Mode: TX Mode

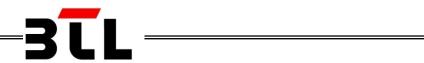
Freq.	Ant.	Reading(RA)	Corr.Factor(CF)	Measured(FS)	Limits(QP)	Margin	Note
(MHz)	0°/90°	(dBuV)	(dB)	(dBuV/m)	(dBuV/m)	(dB)	NOLE
0.0094	0°	76.35	24.97	101.32	108.10	-6.79	AVG
0.0095	0°	82.36	24.97	107.33	128.10	-20.78	PEAK
0.0233	0°	56.38	24.09	80.47	100.26	-19.79	AVG
0.0235	0°	59.35	24.09	83.44	120.26	-36.82	PEAK
0.0315	0°	57.35	23.57	80.92	97.64	-16.72	AVG
0.0316	0°	58.35	23.57	81.92	117.64	-35.72	PEAK
0.0424	0°	59.35	22.88	82.23	95.06	-12.83	AVG
0.0427	0°	63.35	22.88	86.23	115.06	-28.83	PEAK
0.4916	0°	17.45	19.82	37.27	73.77	-36.50	QP
1.7156	0°	18.63	19.53	38.16	69.54	-31.38	QP

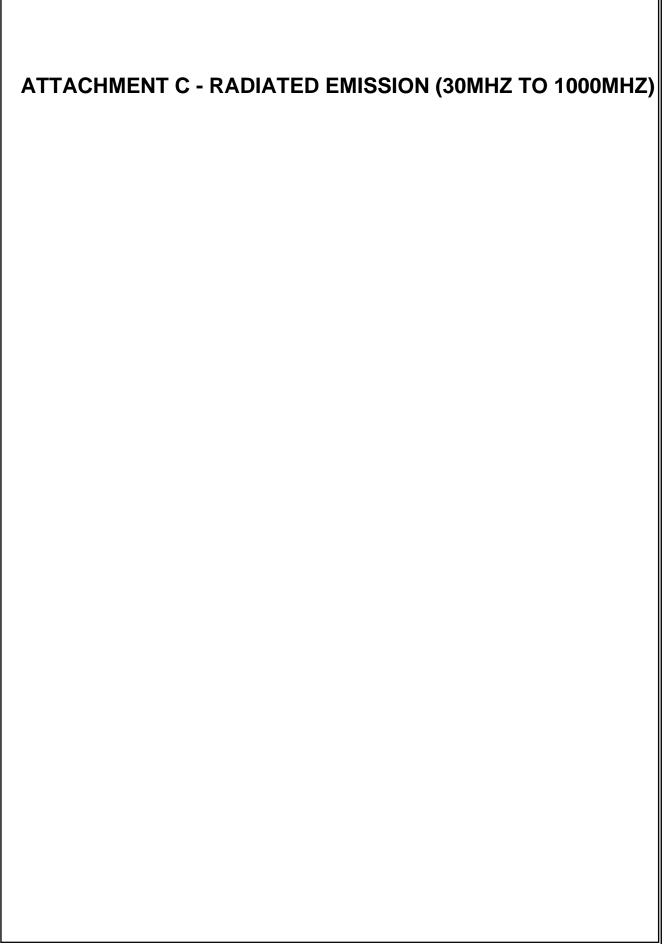
Freq.	Ant.	Reading(RA)	Corr.Factor(CF)	Measured(FS)	Limits(QP)	Margin	Note
(MHz)	0°/90°	(dBuV)	(dB)	(dBuV/m)	(dBuV/m)	(dB)	NOLE
0.0094	90°	76.35	24.30	100.65	128.19	-27.54	AVG
0.0095	90°	82.36	24.30	106.66	148.19	-41.53	PEAK
0.0235	90°	56.38	24.08	80.46	120.18	-39.72	AVG
0.0236	90°	59.35	24.08	83.43	140.18	-56.75	PEAK
0.0314	90°	57.35	23.58	80.93	117.67	-36.74	AVG
0.0316	90°	58.35	23.58	81.93	137.67	-55.74	PEAK
0.0425	90°	59.35	22.88	82.23	115.04	-32.81	AVG
0.0426	90°	63.35	22.88	86.23	135.04	-48.81	PEAK
0.4915	90°	17.45	19.82	37.27	73.77	-36.50	QP
1.7156	90°	18.63	19.53	38.16	69.54	-31.38	QP

Remark:

- (1) The amplitude of spurious emissions which are attenuated by more than 20 dB below the permissible value has no need to be reported.
- (2) Distance extrapolation factor = 40 log (specific distance / test distance) (dB);
- (3) Limit line = specific limits (dBuV) + distance extrapolation factor.

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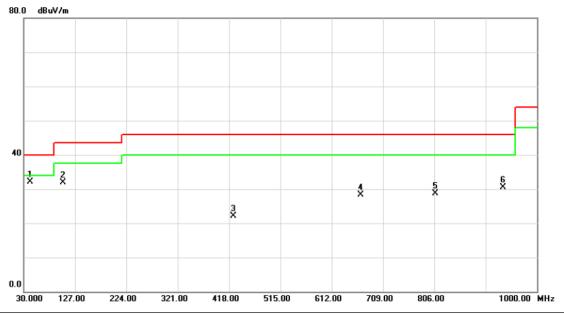


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Test Mode: Band 1/TX A Mode 5180MHz

Vertical



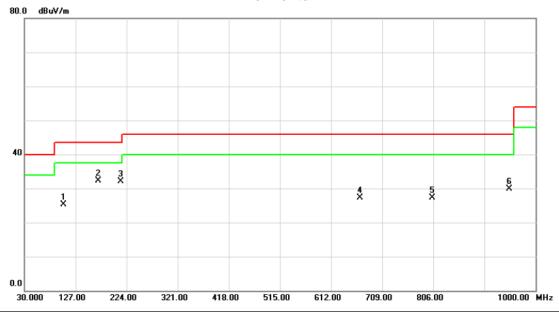
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	41.6400	46.29	-14.12	32.17	40.00	-7.83	peak	
2		103.7200	48.11	-16.11	32.00	43.50	-11.50	peak	
3		426.7300	31.22	-9.14	22.08	46.00	-23.92	peak	
4		666.3200	33.35	-5.12	28.23	46.00	-17.77	peak	
5		807.9400	31.60	-2.97	28.63	46.00	-17.37	peak	
6		935.9800	31.08	-0.67	30.41	46.00	-15.59	peak	

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Test Mode: Band 1/TX A Mode 5180MHz

Horizontal



	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1		103.7200	41.40	-16.11	25.29	43.50	-18.21	peak	
	2	*	170.6500	45.12	-12.78	32.34	43.50	-11.16	peak	
	3		212.3600	47.40	-15.31	32.09	43.50	-11.41	peak	
_	4		666.3200	32.48	-5.12	27.36	46.00	-18.64	peak	
	5		804.0600	30.21	-2.94	27.27	46.00	-18.73	peak	
	6		949.5600	30.29	-0.31	29.98	46.00	-16.02	peak	
_										

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127.00

321.00

Test Mode: Band 1/TX A Mode 5200MHz

Vertical 80.0 dBuV/m 8 8 * 3 X 0.0 30.000 612.00 709.00 806.00 1000.00 MHz

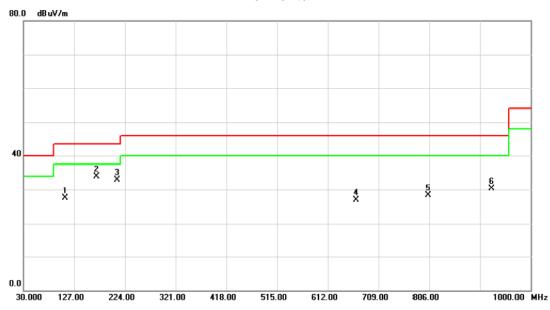
No. M	Лk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1 *	t	41.6400	45.29	-14.12	31.17	40.00	-8.83	peak	
2	1	03.7200	47.61	-16.11	31.50	43.50	-12.00	peak	
3	1	69.6800	38.05	-12.79	25.26	43.50	-18.24	peak	
4	6	66.3200	33.35	-5.12	28.23	46.00	-17.77	peak	
5	8	07.9400	31.60	-2.97	28.63	46.00	-17.37	peak	
6	9	35.9800	30.58	-0.67	29.91	46.00	-16.09	peak	

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Test Mode: Band 1/TX A Mode 5200MHz

Horizontal

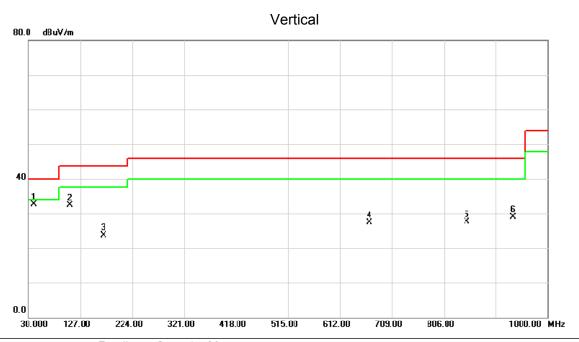


No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		109.5400	43.00	-15.46	27.54	43.50	-15.96	peak	
2	*	170.6500	46.62	-12.78	33.84	43.50	-9.66	peak	
3		208.4800	48.35	-15.35	33.00	43.50	-10.50	peak	
4		666.3200	31.98	-5.12	26.86	46.00	-19.14	peak	
5		804.0600	31.21	-2.94	28.27	46.00	-17.73	peak	
6		925.3100	31.16	-0.95	30.21	46.00	-15.79	peak	

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Test Mode: Band 1/TX A Mode 5240MHz



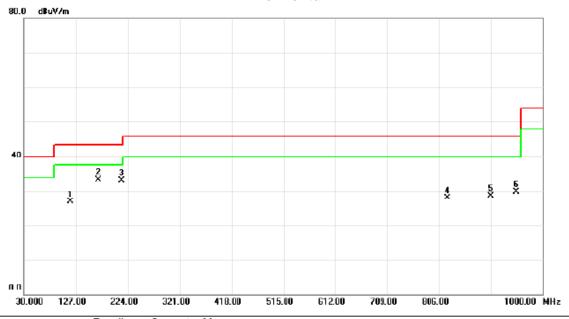
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
_			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	*	40.6700	46.72	-14.28	32.44	40.00	-7.56	peak	
Ī	2	1	108.5700	47.91	-15.57	32.34	43.50	-11.16	peak	
	3	1	169.6800	36.55	-12.79	23.76	43.50	-19.74	peak	
_	4	(666.3200	32.35	-5.12	27.23	46.00	-18.//	peak	
_	5	8	349.6500	30.85	-3.25	27.60	46.00	-18.40	peak	
Ī	6	6	935.9800	29.58	-0.67	28.91	46.00	-17.09	peak	
_										

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Test Mode: Band 1/TX A Mode 5240MHz

Horizontal



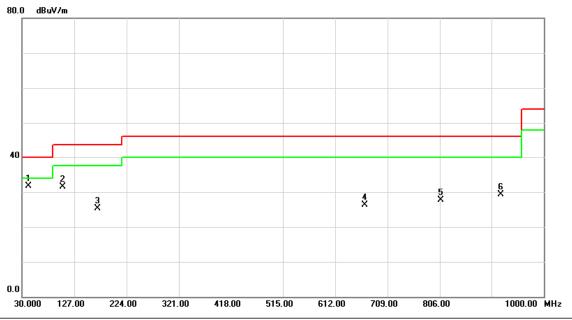
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		117.3000	41.45	-14.56	26.89	43.50	-16.61	peak	
2	*	170.6500	46.12	-12.78	33.34	43.50	-10.16	peak	
3		212.3600	48.40	-15.31	33.09	43.50	-10.41	peak	
4		821.5200	31.16	-3.06	28.10	46.00	-17.90	peak	
5		903.0000	30.32	-1.54	28.78	46.00	-17.22	peak	
6		949.5600	30.29	-0.31	29.98	46.00	-16.02	peak	

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Test Mode: Band 2/TX A Mode 5260MHz

Vertical



	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
-			MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	*	41.6400	45.79	-14.12	31.67	40.00	-8.33	peak	
_	2	1	105.6600	47.42	-15.89	31.53	43.50	-11.97	peak	
-	3	1	169.6800	38.05	-12.79	25.26	43.50	-18.24	peak	
_	4	6	666.3200	31.35	-5.12	26.23	46.00	-19.77	peak	
-	5	8	307.9400	30.60	-2.97	27.63	46.00	-18.37	peak	
-	6	9	920.4600	30.38	-1.08	29.30	46.00	-16.70	peak	
_										

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Test Mode: Band 2/TX A Mode 5260MHz

Horizontal 80.0 dBuV/m **4**D 1 X 2 X ĕ 4 × 0.0 1000 OO MHz 30 000 127 00 224 NA 321 NA 418 NA 515 00 612 00 709 00 806 00

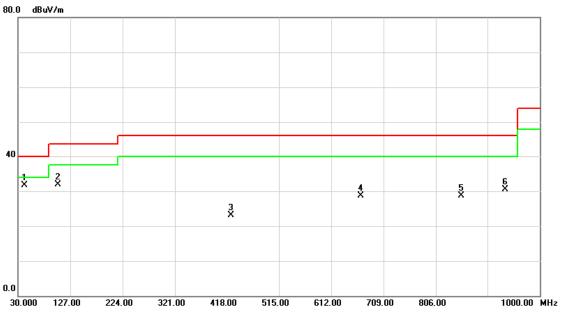
No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	170.6500	46.12	-12.78	33.34	43.50	-10.16	peak	
2		212.3600	46.90	-15.31	31.59	43.50	-11.91	peak	
3		233.7000	40.97	-14.22	26.75	46.00	-19.25	peak	
4		666.3200	31.98	-5.12	26.86	46.00	-19.14	peak	
5		804 0600	31 71	-2 94	28 77	46 00	-17 23	peak	
6		949.5600	30.29	-0.31	29.98	46.00	-16.02	peak	

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Test Mode: Band 2/TX A Mode 5300MHz

Vertical



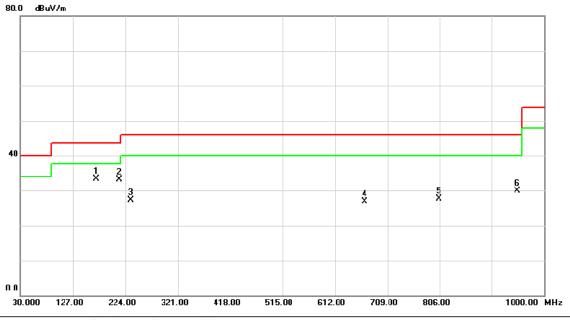
	Mk.	Freq.	Level	Factor	ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	41.6400	45.79	-14.12	31.67	40.00	-8.33	peak	
2	,	103.7200	48.11	-16.11	32.00	43.50	-11.50	peak	
3	4	426.7300	32.22	-9.14	23.08	46.00	-22.92	peak	
4	(666.3200	33.85	-5.12	28.73	46.00	-17.27	peak	
5	8	854.5000	31.87	-3.10	28.77	46.00	-17.23	peak	
6	(935.9800	31.08	-0.67	30.41	46.00	-15.59	peak	

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Test Mode: Band 2/TX A Mode 5300MHz

Horizontal



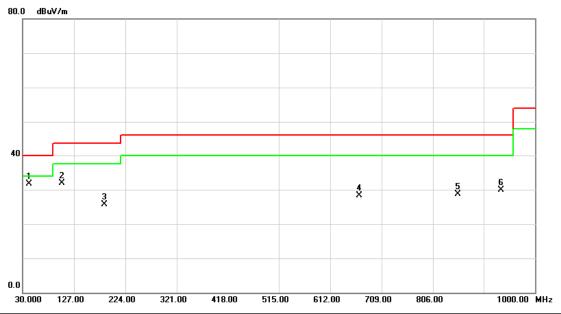
	No.	Mk.	Freq.	Reading I evel	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	*	170.6500	46.12	-12.78	33.34	43.50	-10.16	peak	
	2		212.3600	48.40	-15.31	33.09	43.50	-10.41	peak	
	3		233.7000	41.47	-11.22	27.25	46.00	-18.75	peak	
_	4		666.3200	31.98	-5.12	26.86	46.00	-19.14	peak	
-	5		804.0600	30.71	-2.94	27.77	46.00	-18.23	peak	
	6		949.5600	30.29	-0.31	29.98	46.00	-16.02	peak	
_										

Report No.: NEI-FCCP-1-1406C191 Page 50 of 215



Test Mode: Band 2/TX A Mode 5320MHz

Vertical



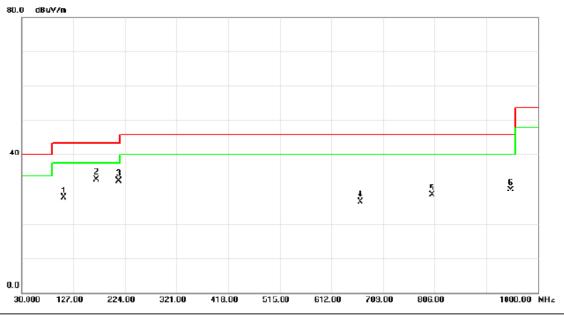
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	41.6400	45.79	-14.12	31.67	40.00	-8.33	peak	
2	,	103.7200	48.11	-16.11	32.00	43.50	-11.50	peak	
3	,	184.2300	39.34	-13.67	25.67	43.50	-17.83	peak	
4	6	666.3200	33.35	-5.12	28.23	46.00	-17.77	peak	
5	8	354.5000	31.87	-3.10	28.77	46.00	-17.23	peak	
6	(935.9800	30.58	-0.67	29.91	46.00	-16.09	peak	

Report No.: NEI-FCCP-1-1406C191 Page 51 of 215



Test Mode: Band 2/TX A Mode 5320MHz

Horizontal



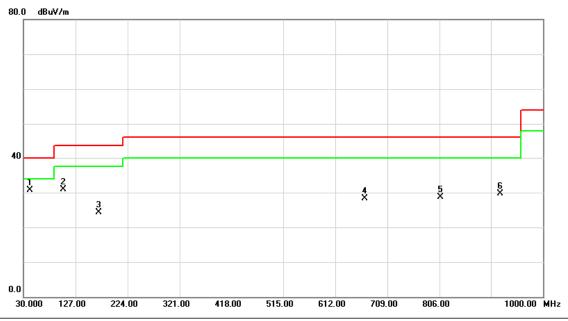
No	. М	k. Froq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		109.5400	43.00	-15.46	27.54	43.50	-15.96	peak	
2	*	170.6500	45.62	-12.78	32.84	43.50	-10.66	peak	
3	}	212.3600	47.90	-15.31	32.59	43.50	-10.91	peak	
4		666.3200	31.48	-5.12	26.36	46.00	-19.64	peak	
5	,	801.1500	31.15	-2.92	28.23	46.00	-17.77	peak	
6	,	949.5600	30.29	-0.31	29.98	46.00	-16.02	peak	

Report No.: NEI-FCCP-1-1406C191 Page 52 of 215



Test Mode: Band 3/TX A Mode 5500MHz

Vertical



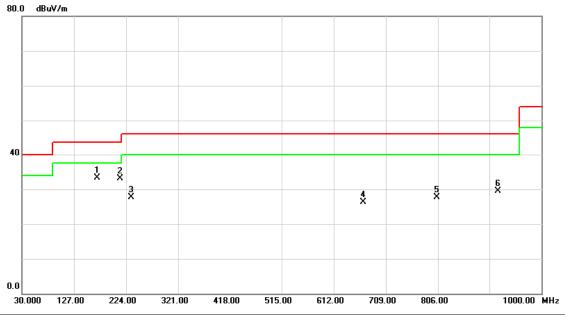
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
-			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
-	1	*	41.6400	44.79	-14.12	30.67	40.00	-9.33	peak	
-	2	1	03.7200	47.11	-16.11	31.00	43.50	-12.50	peak	
-	3	1	69.6800	37.05	-12.79	24.26	43.50	-19.24	peak	
-	4	6	666.3200	33.35	-5.12	28.23	46.00	-17.77	peak	
-	5	8	807.9400	31.60	-2.97	28.63	46.00	-17.37	peak	
-	6	9	20.4600	30.88	-1.08	29.80	46.00	-16.20	peak	
-										

Report No.: NEI-FCCP-1-1406C191 Page 53 of 215



Test Mode: Band 3/TX A Mode 5500MHz

Horizontal



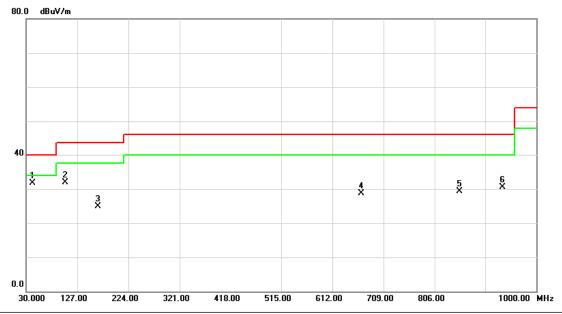
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	170.6500	46.12	-12.78	33.34	43.50	-10.16	peak	
2		212.3600	48.40	-15.31	33.09	43.50	-10.41	peak	
3		233.7000	41.97	-14.22	27.75	46.00	-18.25	peak	
4		666.3200	31.48	-5.12	26.36	46.00	-19.64	peak	
5		804.0600	30.71	-2.94	27.77	46.00	-18.23	peak	
6		919.4900	30.67	-1.10	29.57	46.00	-16.43	peak	

Report No.: NEI-FCCP-1-1406C191 Page 54 of 215



Test Mode: Band 3/TX A Mode 5580MHz

Vertical



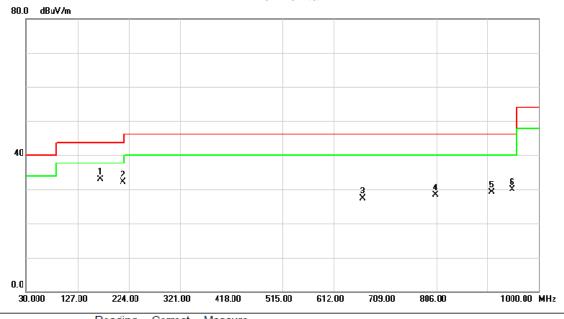
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	41.6400	45.79	-14.12	31.67	40.00	-8.33	peak	
2		103.7200	48.11	-16.11	32.00	43.50	-11.50	peak	
3		165.8000	38.07	-13.23	24.84	43.50	-18.66	peak	
4		666.3200	33.85	-5.12	28.73	46.00	-17.27	peak	
5		854.5000	32.37	-3.10	29.27	46.00	-16.73	peak	
6		935.9800	31.08	-0.67	30.41	46.00	-15.59	peak	

Report No.: NEI-FCCP-1-1406C191 Page 55 of 215



Test Mode: Band 3/TX A Mode 5580MHz

Horizontal



	No.	Mk	. Froq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
_			MHZ	dBuV	dВ	dBuV/m	dBuV/m	dВ	Detector	Comment
	1	*	170.6500	45.62	-12.78	32.84	43.50	-10.66	peak	
_	2		212.3600	47.40	-15.31	32.09	43.50	-11.41	peak	
_	3		666.3200	32.48	-5.12	27.36	46.00	-18.64	peak	
_	4		804.0600	31.21	-2.94	28.27	46.00	-17.73	peak	
_	5		911.7300	30.48	-1.31	29.17	46.00	-16.83	peak	
	6		949.5600	30.29	-0.31	29.98	46.00	-16.02	peak	
_										

Report No.: NEI-FCCP-1-1406C191 Page 56 of 215



30.000

127.00

224.00

321.00

418.00

Test Mode: Band 3/TX A Mode 5700MHz

	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
_			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
_	1	*	41.6400	45.79	-14.12	31.67	40.00	-8.33	peak	
_	2	1	103.7200	47.11	-16.11	31.00	43.50	-12.50	peak	
_	3	1	169.6800	37.55	-12.79	24.76	43.50	-18.74	peak	
	4	6	666.3200	33.85	-5.12	28.73	46.00	-17.27	peak	
	5	8	307.9400	32.10	-2.97	29.13	46.00	-16.87	peak	
_	6	ć	935.9800	30.58	-0.67	29.91	46.00	-16.09	peak	

515.00

612.00

709.00

806.00

1000.00 MHz

Report No.: NEI-FCCP-1-1406C191 Page 57 of 215



80.0 dBuV/m

0.0

30.000 127.00

Test Mode: Band 3/TX A Mode 5700MHz

224.00

321.00

418.00

612.00

709.00

806.00

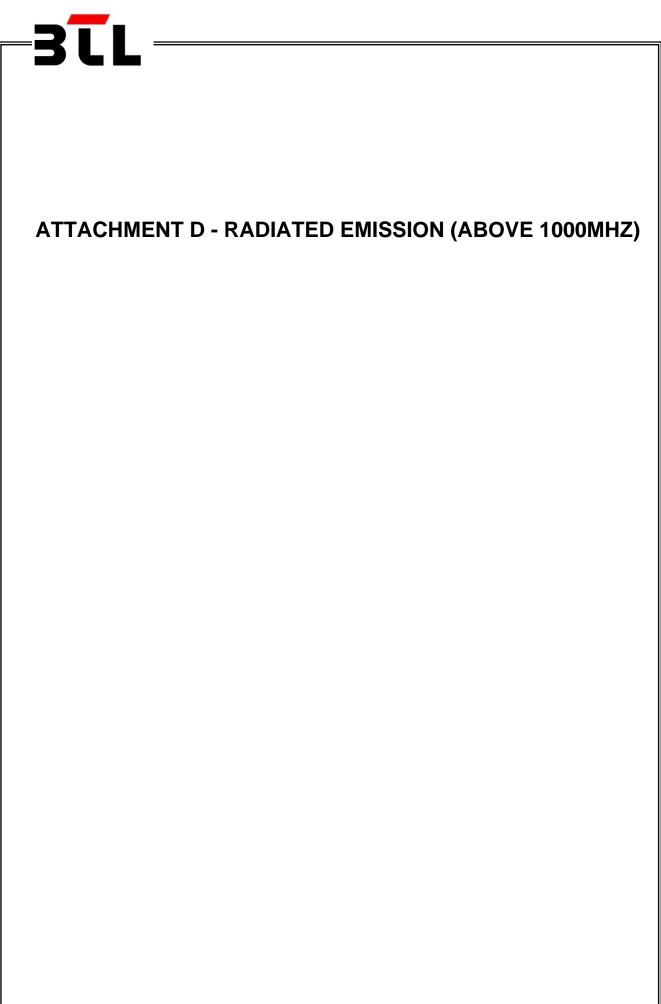
1000.00 MHz

No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		155.1300	42.75	-13.56	29.19	43.50	-14.31	peak	
2	*	170.6500	46.12	-12.78	33.34	43.50	-10.16	peak	
3		212.3600	46.90	-15.31	31.59	43.50	-11.91	peak	
4		666.3200	31.98	-5.12	26.86	46.00	-19.14	peak	
5		821.5200	31.16	-3.06	28.10	46.00	-17.90	peak	
6		907.8500	30.24	-1.41	28.83	46.00	-17.17	peak	

515.00

Report No.: NEI-FCCP-1-1406C191 Page 58 of 215



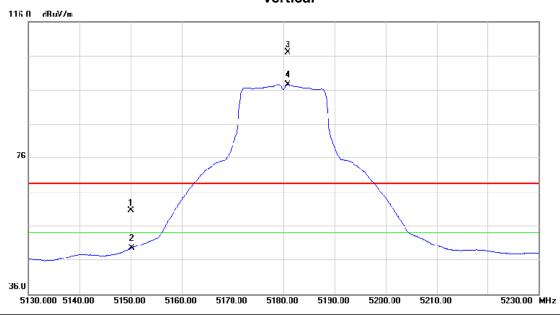


Report No.: NEI-FCCP-1-1406C191 Page 59 of 215



Test Mode: Band 1/ TX A Mode 5180MHz

Vertical



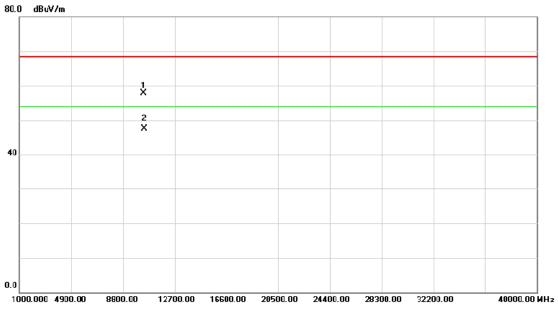
	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
_	1		5150.000	18.59	41.99	60.58	68.30	-7.72	peak	
	2		5150.000	7.27	41.99	49.26	54.00	-4.74	AVG	
	3	Χ	5180.900	64.92	42.12	107.04	68.30	38.74	peak	Fundamental frequency, no limit
_	4	¥	5180.900	55.43	42.12	97.55	54.00	43.55	AVG	Fundamental frequency, no limit
_										

Report No.: NEI-FCCP-1-1406C191 Page 60 of 215



Test Mode: Band 1/ TX A Mode 5180MHz

Vertical



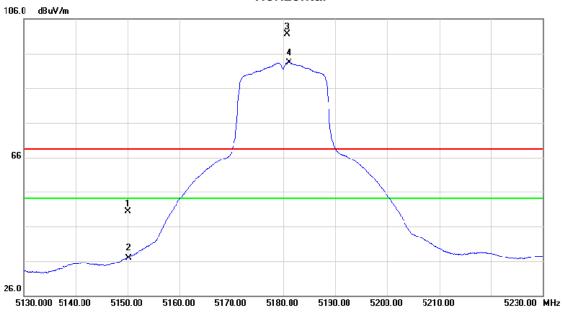
No.	Mk	c. Froq.			Measure- ment		Over		
		MI Iz	dBu∨	dB	dBu∨/m	dBu∀/m	dB	Detector	Comment
1		10357.55	42.30	15./0	58.00	68.30	-10.30	peak	
2	*	10358.00	31.91	15.70	47.61	54.00	-6.39	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 61 of 215



Test Mode: Band 1/ TX A Mode 5180MHz

Horizontal



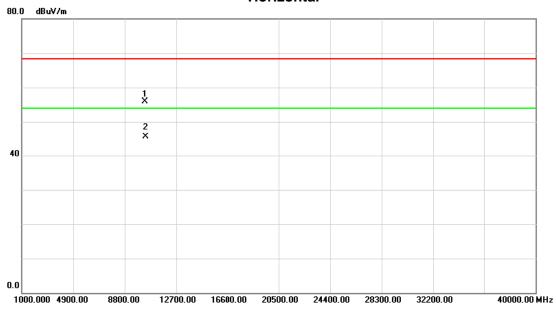
No	. Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		5150.000	8.22	41.99	50.21	68.30	-18.09	peak	
2		5150.000	-5.05	41.99	36.94	54.00	-17.06	AVG	
3	X	5180.700	59.39	42.12	101.51	68.30	33.21	peak	Fundamental frequency, no limit
4	٨	5181.100	51.27	42.12	93.39	54.00	39.39	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 62 of 215



Test Mode: Band 1/ TX A Mode 5180MHz

Horizontal



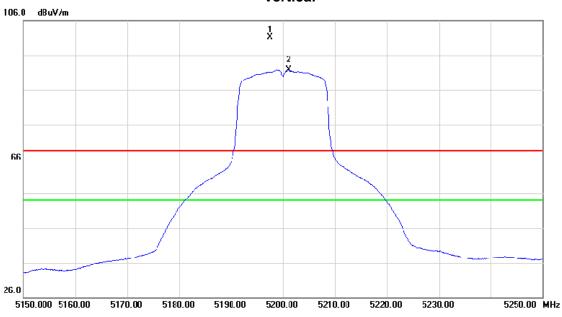
No.	Mk	. Freq.			Measure- ment		Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10356.70	40.29	15.70	55.99	68.30	-12.31	peak	
2	*	10358.35		15.70	45.48	54.00	-8.52	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 63 of 215



Test Mode: Band 1/ TX A Mode 5200MHz

Vertical



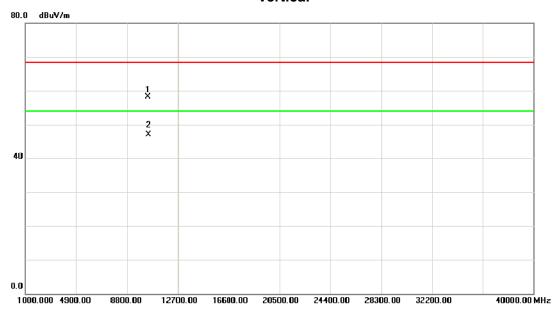
No.	. M	1k.	Freq.	Reading Level		Measure- ment	Limit	Over		
			MH∠	dBuV	dB	dBuV/m	dBuV/m	dB	Delector	Comment
1	X	(5	197.500	58.93	42.18	101.11	68.30	32.81	peak	Fundamental frequency, no limit
2	۸	52	201.100	49.53	42.20	91.73	54.00	37.73	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 64 of 215



Test Mode: Band 1/ TX A Mode 5200MHz

Vertical



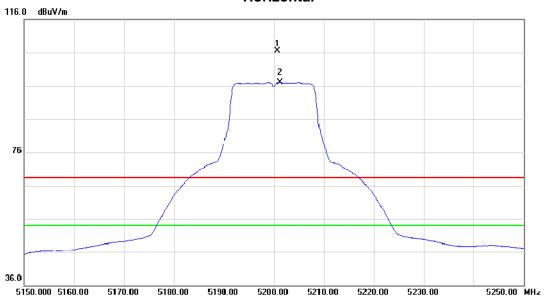
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10399.35	42.51	15.64	58.15	68.30	-10.15	peak	
2	*	10401.25	31.24	15.63	46.87	54.00	-7.13	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 65 of 215



Test Mode: Band 1/ TX A Mode 5200MHz

Horizontal



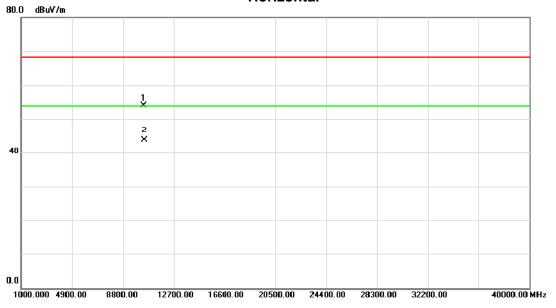
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	X	5200.700	64.29	42.20	106.49	68.30	38.19	peak	Fundamental frequency, no limit
2	*	5201.200	54.98	42.20	97.18	54.00	43.18	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 66 of 215



Test Mode: Band 1/ TX A Mode 5200MHz

Horizontal



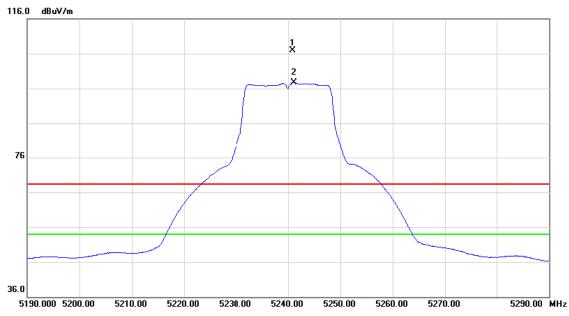
No). N	Лk.				Measure- ment		Over		
			MHz	dBuV	₫B	dBuV/m	dBuV/m	dB	Detector	Comment
1	1	10	400.55	38.55	15.64	54.19	68.30	-14.11	peak	
2	2 *	10	401.10	28.07	15.63	43.70	54.00	-10.30	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 67 of 215



Test Mode: Band 1/ TX A Mode 5240MHz

Vertical



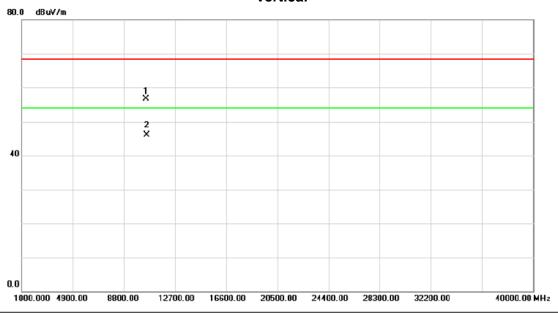
_	No.	M	۲.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
				MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
Ī	1	X	52	40.900	64.62	42.37	106.99	68.30	38.69	peak	Fundamental frequency, no limit
	2	*	52	41.100	55.30	42.37	97.67	54.00	43.67	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 68 of 215



Test Mode: Band 1/ TX A Mode 5240MHz

Vertical



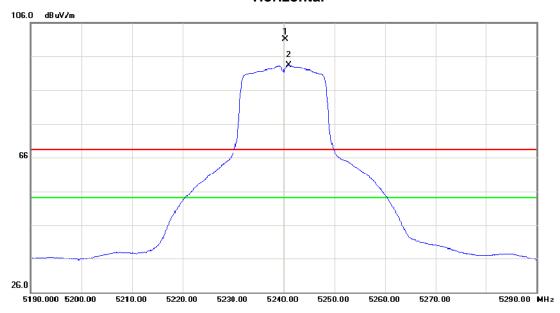
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dВ	Detector	Comment
1		10479.85	41.25	15.52	56.77	68.30	-11.53	peak	
2		10481.50			46.13	54.00	-7.87	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 69 of 215



Test Mode: Band 1/ TX A Mode 5240MHz

Horizontal



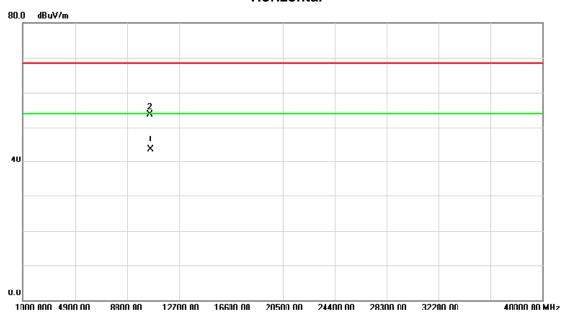
	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
_			MHz	dBuV	dB	dBuV/m	dBuV/m	₫B	Detector	Comment
-	1	X	5240.300	58.76	42.37	101.13	68.30	32.83	peak	Fundamental frequency, no limit
	2	*	5241.000	51.12	42.37	93.49	54.00	39.49	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 70 of 215



Test Mode: Band 1/ TX A Mode 5240MHz

Horizontal



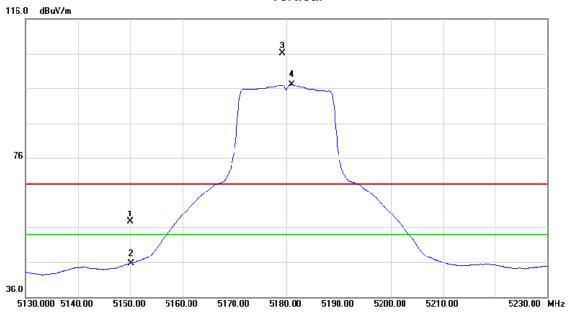
No.	Mk	c. Freq.			Measure- ment		Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	10480.65	28.08	15.51	43.59	54.00	-10.41	AVG	
2		10481.00	38.12	15.51	53.63	68.30	-14.67	peak	

Report No.: NEI-FCCP-1-1406C191 Page 71 of 215



Test Mode: Band 1/ TX N20 Mode 5180MHz

Vertical



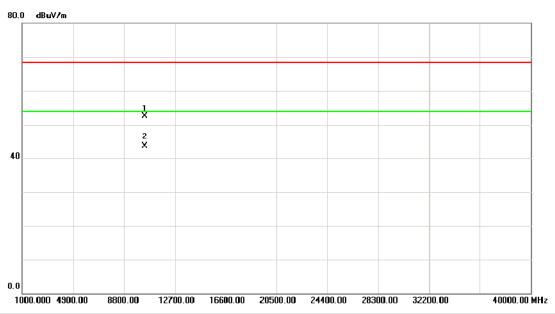
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		5150.000	15.60	41.99	57.59	68.30	-10.71	peak	
2		5150.000	3.54	41.99	45.53	54.00	-8.47	AVG	
3	Χ	5179.300	63.95	42.12	106.07	68.30	37.77	peak	Fundamental frequency, no limit
4	*	5181.000	54.93	42.12	97.05	54.00	43.05	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 72 of 215



Test Mode: Band 1/ TX N20 Mode 5180MHz

Vertical



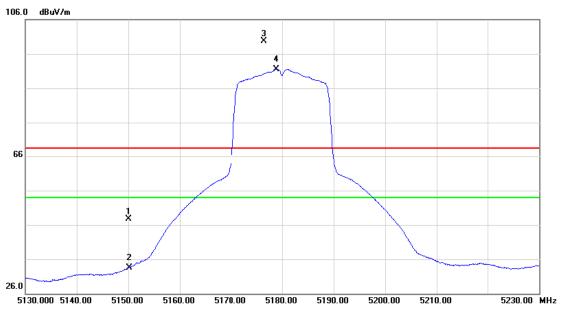
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10360.12	36.43	16.03	52.46	68.30	-15.84	peak	
2	*	10360.12	27.46	16.03	43.49	54.00	-10.51	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 73 of 215



Test Mode: Band 1/ TX N20 Mode 5180MHz

Horizontal



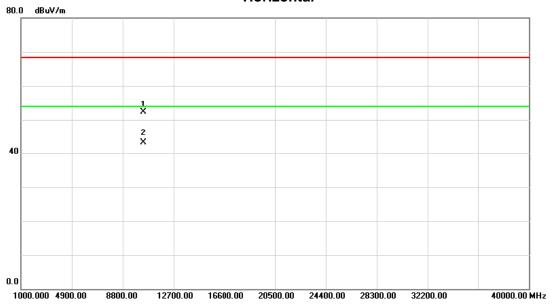
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		5150.000	5.67	41.99	47.66	68.30	-20.64	peak	
2		5150.000	-8.46	41.99	33.53	54.00	-20.47	AVG	
3	Χ	5176.500	57.56	42.10	99.66	68.30	31.36	peak	Fundamental frequency, no limit
4	*	5178.900	49.42	42.11	91.53	54.00	37.53	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 74 of 215



Test Mode: Band 1/ TX N20 Mode 5180MHz

Horizontal

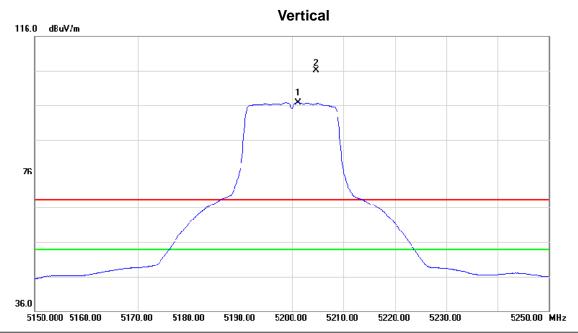


1	No. M	lk.	Freq.	Reading Level		Measure- ment	Limit	Over		
			MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	10	0360.60	36.23	16.03	52.26	68.30	-16.04	peak	
	_			27.05		43.08	54.00	-10.92	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 75 of 215



Test Mode: Band 1/ TX N20 Mode 5200MHz



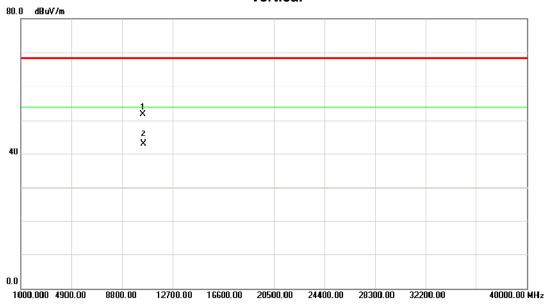
	No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	n	5201.200	54.50	42.20	96.70	54.00	42.70	AVG	Fundamental frequency, no limit
Ī	2	X	5204.700	63.85	42.22	106.07	68.30	37.77	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 76 of 215



Test Mode: Band 1/ TX N20 Mode 5200MHz

Vertical



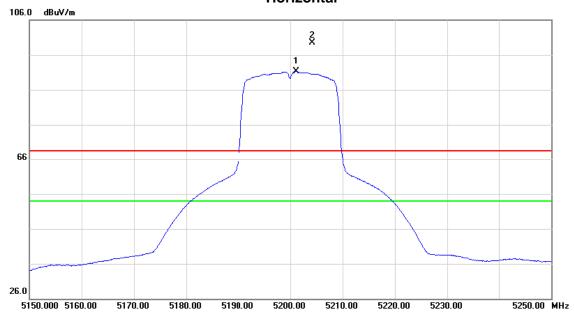
No.	Mk	. Freq.	_	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10400.09	35.79	15.97	51.76	68.30	-16.54	peak	
2	*	10400.09	26.84	15.97	42.81	54.00	-11.19	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 77 of 215



Test Mode: Band 1/ TX N20 Mode 5200MHz

Horizontal



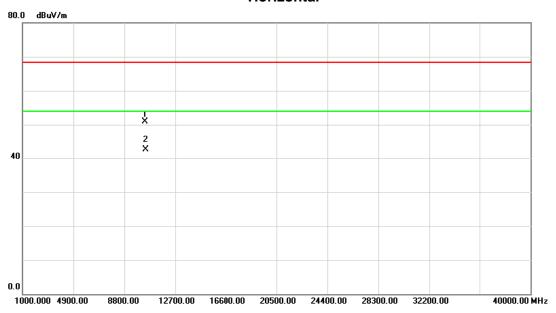
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	5201.100	49.07	42.20	91.27	54.00	37.27	AVG	Fundamental frequency, no limit
2	X	5204.200	57.33	42.22	99.55	68.30	31.25	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 78 of 215



Test Mode: Band 1/ TX N20 Mode 5200MHz

Horizontal



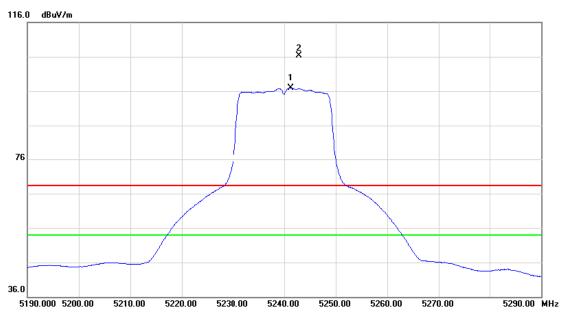
No.	Mk	. Freq.	Reading Level		Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10399.96	35.01	15.97	50.98	68.30	-17.32	peak	
2	*	10399.96	26.48	15.97	42.45	54.00	-11.55	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 79 of 215



Test Mode: Band 1/ TX N20 Mode 5240MHz

Vertical



_	No.	Mk	k. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	*	5241.200	54.57	42.37	96.94	54.00	42.94	AVG	Fundamental frequency, no limit
	2	X	5242.800	63.91	42.37	106.28	68.30	37.98	peak	Fundamental frequency, no limit

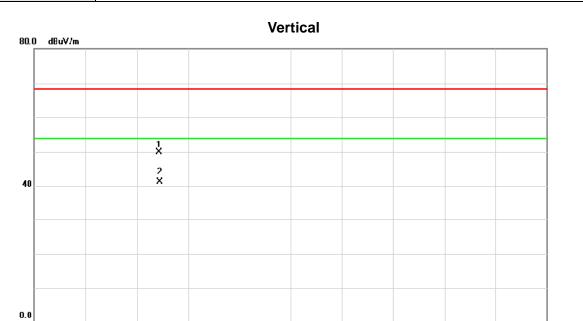
Report No.: NEI-FCCP-1-1406C191 Page 80 of 215



1000.000 4900.00

8800.00

Test Mode: Band 1/ TX N20 Mode 5240MHz



No.	Mk	. Freq.	Reading Level		Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBu∨/m	dB	Detector	Comment
1		10480.64	34.01	15.85	49.86	68.30	-18.44	peak	
2	*	10480.64		15.85	41.16	54.00	-12.84	AVG	

12700.00 16600.00 20500.00 24400.00 28300.00 32200.00

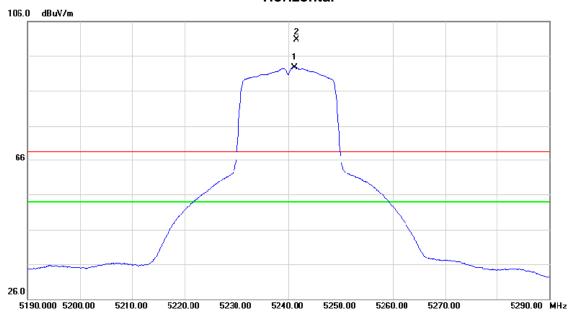
40000.00 MHz

Report No.: NEI-FCCP-1-1406C191 Page 81 of 215



Test Mode: Band 1/ TX N20 Mode 5240MHz

Horizontal



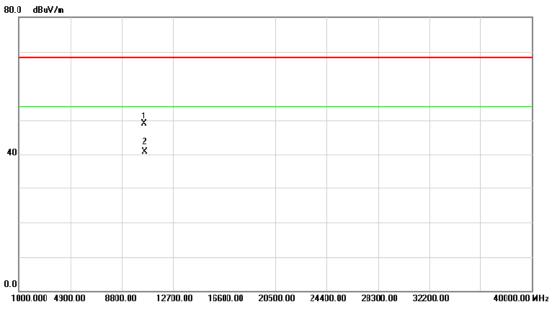
No	. M	lk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	52	241.100	50.37	42.37	92.74	54.00	38.74	AVG	Fundamental frequency, no limit
2	X	52	241.500	58.24	42.37	100.61	68.30	32.31	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 82 of 215



Test Mode: Band 1/ TX N20 Mode 5240MHz

Horizontal



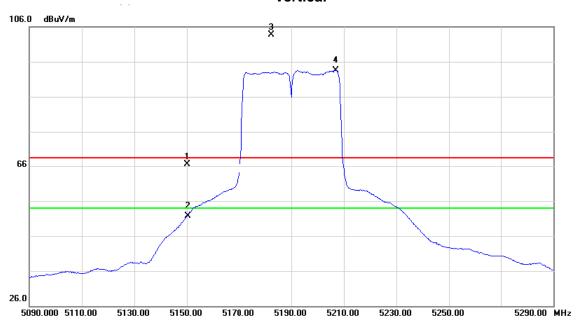
No.	Mk	k. Freq.			Measure- ment		Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10480.47	33.23	15.85	49.08	68.30	-19.22	peak	
2	*	10480.47	24.80	15.85	40.65	54.00	-13.35	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 83 of 215



Test Mode: Band 1/ TX N40 Mode 5190MHz

Vertical



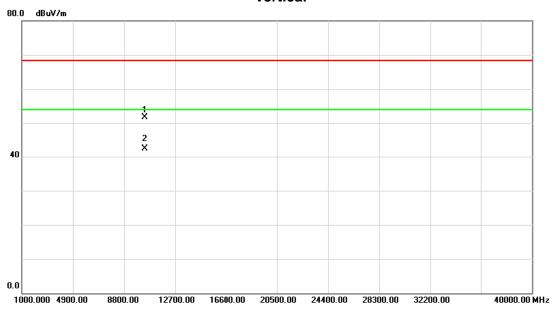
	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1		5150.000	24.50	41.99	66.49	68.30	-1.81	peak	
_	2		5150.000	9.63	41.99	51.62	54.00	-2.38	AVG	
	3	X	5182.400	61.53	42.13	103.66	68.30	35.36	peak	Fundamental frequency, no limit
	4	*	5207.000	51.24	42.23	93.47	54.00	39.47	AVG	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 84 of 215



Test Mode: Band 1/ TX N40 Mode 5190MHz

Vertical



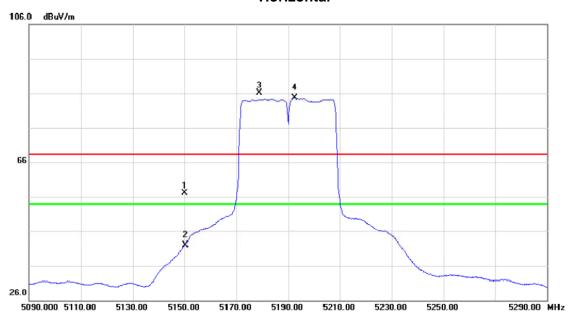
No.	Mk	. Freq.	Reading Level		Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10380.97		16.00	51.64	68.30	-16.66	peak	
2	*		26.35		42.35	54.00	-11.65	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 85 of 215



Test Mode: Band 1/ TX N40 Mode 5190MHz

Horizontal



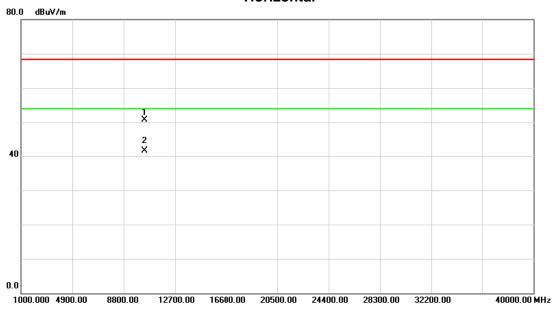
	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBu∨	d₿	dBuV/m	dBuV/m	d₿	Detector	Comment
	1		5150.000	15.19	41.99	57.18	68.30	-11.12	peak	
_	2		5150.000	-0.09	41.99	41.90	54.00	-12.10	AVG	
_	3	Χ	5179.000	43.93	42.11	86.04	68.30	17.74	peak	Fundamental frequency,no limit
_	4	*	5192.400	42.58	42.16	84.74	54.00	30.74	AVG	Fundamental frequency,no limit
_										

Report No.: NEI-FCCP-1-1406C191 Page 86 of 215



Test Mode: Band 1/ TX N40 Mode 5190MHz

Horizontal



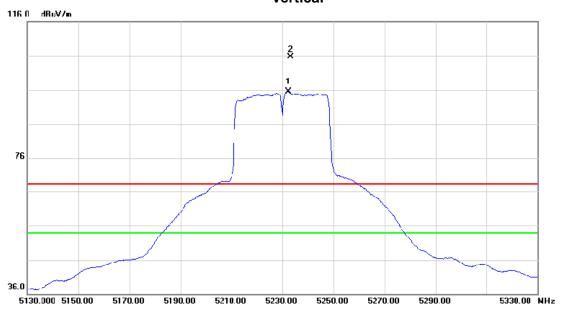
No.	Mk	. Freq.	_	Correct Factor	Measure- ment		Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10380.60	34.62	16.00	50.62	68.30	-17.68	peak	
2	*	10380.60	25.58	16.00	41.58	54.00	-12.42	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 87 of 215



Test Mode: Band 1/ TX N40 Mode 5230MHz

Vertical



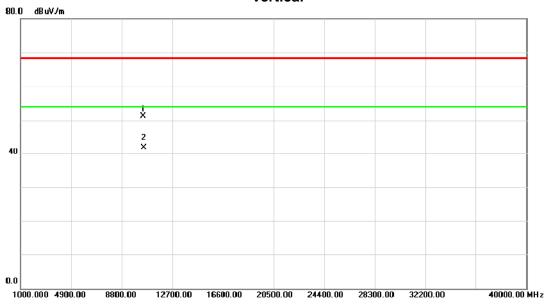
N	0.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	*	5232.400	53.13	42.33	95.46	54.00	41.46	AVG	Fundamental frequency, no limit
	2	X	5233.200	63.29	42.33	105.62	68.30	37.32	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 88 of 215



Test Mode: Band 1/ TX N40 Mode 5230MHz

Vertical



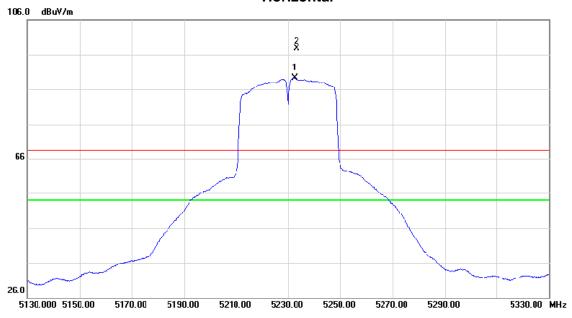
No.	. Mk	. Freq.			Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10460.37	35.18	15.88	51.06	68.30	-17.24	peak	
2	*	10460.37	25.76	15.88	41.64	54.00	-12.36	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 89 of 215



Test Mode: Band 1/ TX N40 Mode 5230MHz

Horizontal



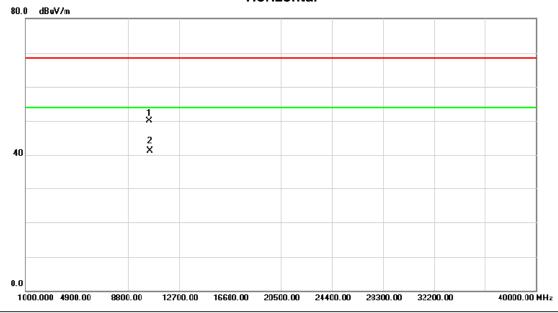
No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	k	5232.400	46.98	42.33	89.31	54.00	35.31	AVG	Fundamental frequency, no limit
2	X	5233.200	55.45	42.33	97.78	68.30	29.48	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 90 of 215



Test Mode: Band 1/ TX N40 Mode 5230MHz

Horizontal



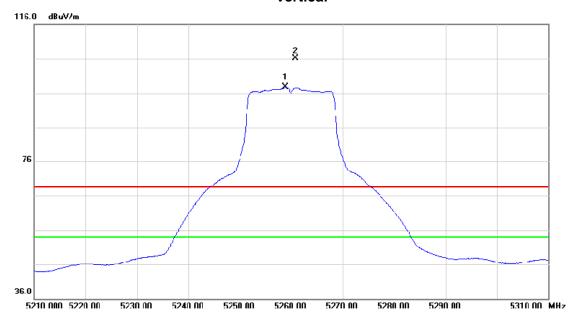
No.	Mk.	Freq.			Measure- ment		Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10459.80	34.31	15.88	50.19	68.30	-18.11	peak	
2	*	10459.80	25.23	15.88	41.11	54.00	-12.89	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 91 of 215



Test Mode: Band 2/ TX A Mode 5260MHz

Vertical



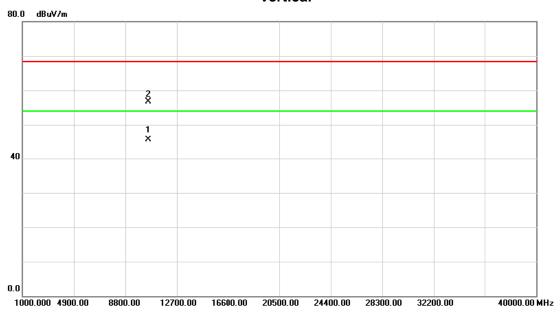
No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	¥	5258.900	55.23	42.43	97.66	54.00	43.66	AVG	Fundamental frequency, no limit
2	Χ	5260.900	63.72	42.45	106.17	68.30	37.87	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 92 of 215



Test Mode: Band 2/ TX A Mode 5260MHz

Vertical



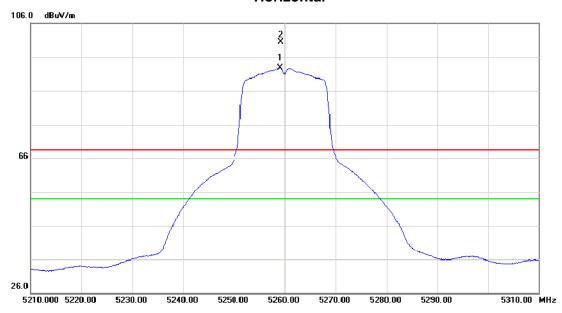
No.	Mk	. Freq.	Reading Level		Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	10518.70	30.09	15.47	45.56	54.00	-8.44	AVG	
2		10520.40			56.72	68.30	-11.58	peak	

Report No.: NEI-FCCP-1-1406C191 Page 93 of 215



Test Mode: Band 2/ TX A Mode 5260MHz

Horizontal



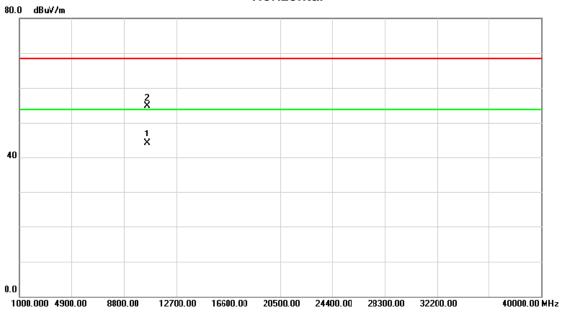
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	5259.100	50.30	42.43	92.73	54.00	38.73	AVG	Fundamental frequency, no limit
2	X	5259.200	57.84	42.43	100.27	68.30	31.97	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 94 of 215



Test Mode: Band 2/ TX A Mode 5260MHz

Horizontal



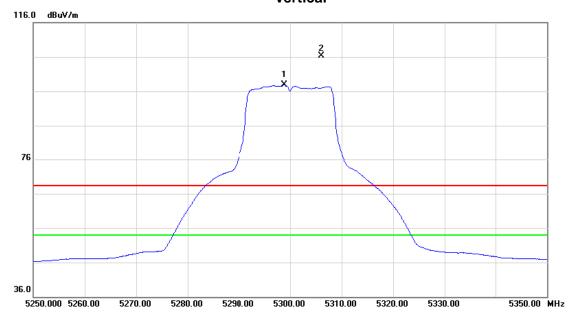
No.	Mk	. Freq.			Measure- ment		Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	10518.30	28.46	15.47	43.93	54.00	-10.07	AVG	
2		10518.60		15.47	54.88	68.30	-13.42	peak	

Report No.: NEI-FCCP-1-1406C191 Page 95 of 215



Test Mode: Band 2/ TX A Mode 5300MHz

Vertical



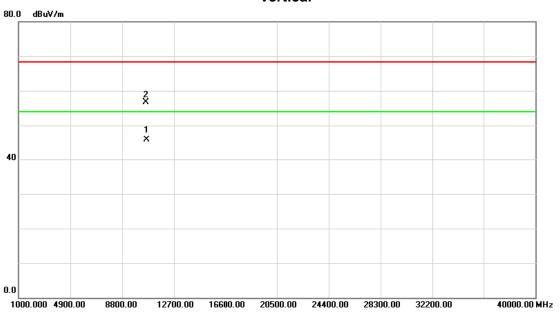
No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1 * 5	298.800	55.27	42.60	97.87	54.00	43.87	AVG	Fundamental frequency, no limit
2 X 5	306.000	63.61	42.63	106.24	68.30	37.94	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 96 of 215



Test Mode: Band 2/ TX A Mode 5300MHz

Vertical



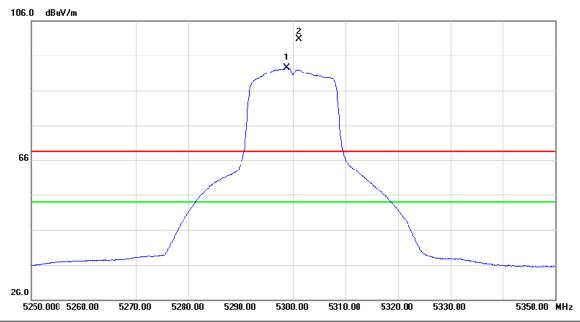
No.	Mk	. Freq.			Measure- ment		Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	10599.85	30.27	15.45	45.72	54.00	-8.28	AVG	
2		10602.50		15.44	56.70	68.30	-11.60	peak	

Report No.: NEI-FCCP-1-1406C191 Page 97 of 215



Test Mode: Band 2/ TX A Mode 5300MHz

Horizontal

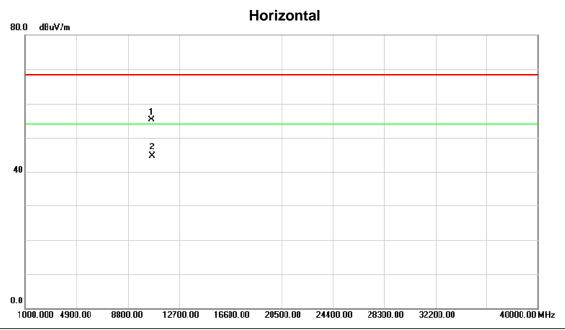


No.	M	k. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	5298.900	49.95	42.60	92.55	54.00	38.55	AVG	Fundamental frequency, no limit
2	X	5301.100	58.03	42.60	100.63	68.30	32.33	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 98 of 215



Test Mode: Band 2/ TX A Mode 5300MHz



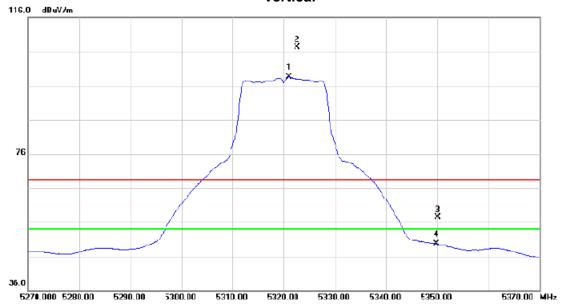
No.	Mk.	Freq.	Reading Level		Measure ment	Limit	Over		
		MHZ	dBu√	dB	dBuV/m	dBu∨/m	dB	Detector	Comment
1		10598.70		15.45	55.32	68.30	-12.98	peak	
2		10600.20		15.45	44.43	54.00	-9.57	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 99 of 215



Test Mode: Band 2/ TX A Mode 5320MHz

Vertical



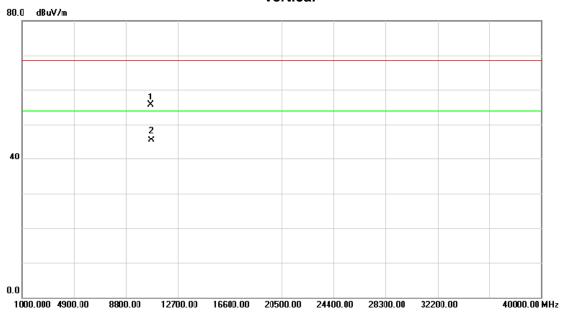
No	ο.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBuV	dB	dBu\/m	dBuV/m	dB	Detector	Comment
-	1	*	5321.000	55.83	42.69	98.52	54.00	44.52	AVG	Fundamental frequency, no limit
	2	Х	5322.600	64.66	42.69	107.35	68.30	39.05	peak	Fundamental frequency, no limit
,	3		5350.000	14.62	42.81	57.43	68.30	-10.87	peak	
4	4		5350.000	6.68	42.81	49.49	54.00	-4.51	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 100 of 215



Test Mode: Band 2/ TX A Mode 5320MHz

Vertical



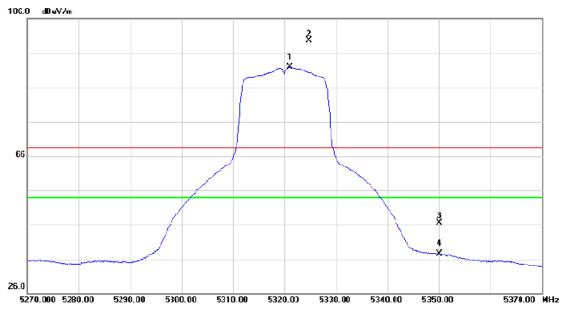
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10639.80		15.43	55.78	68.30	-12.52	peak	
2	*	10640.05	29.88	15.43	45.31	54.00	-8.69	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 101 of 215



Test Mode: Band 2/ TX A Mode 5320MHz

Horizontal



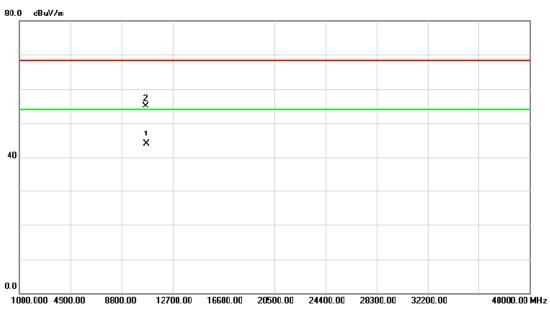
No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	5321.000	49.23	42.69	91.92	54.00	37.92	AVG	Fundamental frequency, no limit
2	X	5324.700	56.85	42.71	99.56	68.30	31.26	peak	Fundamental frequency, no limit
3		5350 000	3 71	42 81	46 52	68 30	-2178	peak	
4		5350.000	-5.27	42.81	37.54	54.00	-16.46	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 102 of 215



Test Mode: Band 2/ TX A Mode 5320MHz

Horizontal



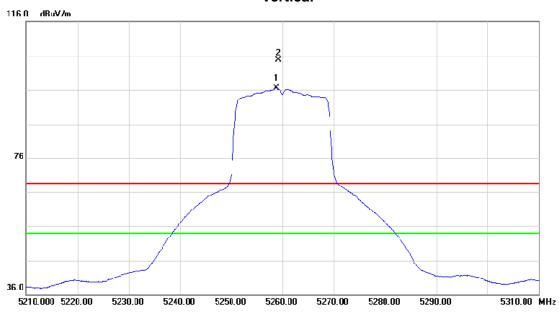
No.	Mk	. Freq.			Measure- ment		Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	A	10639.65	28.51	15.43	43.94	54.00	-10.06	AVG	
2		10640 20			55 05	68 30	-13 25	peak	

Report No.: NEI-FCCP-1-1406C191 Page 103 of 215



Test Mode: Band 2/ TX N20 Mode 5260MHz

Vertical

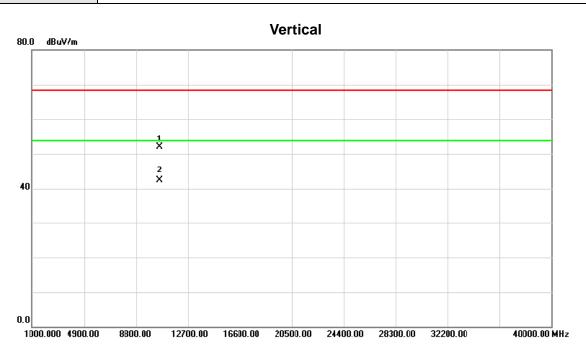


No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	5258.800	54.01	42.43	96.44	54.00	42.44	ΛVG	Fundamental frequency, no limit
2	X	5259.200	62.23	42.43	104.66	68.30	36.36	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 104 of 215



Test Mode: Band 2/ TX N20 Mode 5260MHz



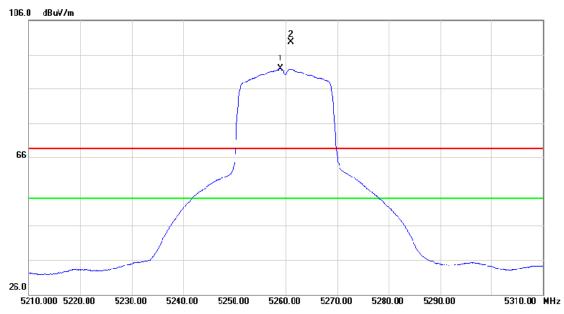
No.	. Mk	k. Freq.	Reading Level		Measure- ment		Over		
		MHz	dBu∀	dB	dBuV/m	dBu∀/m	dB	Delector	Comment
1		10520.76	36.29	15.88	52.17	68.30	-16.13	peak	
2			26.41		42.29	54.00	-11.71	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 105 of 215



Test Mode: Band 2/ TX N20 Mode 5260MHz

Horizontal



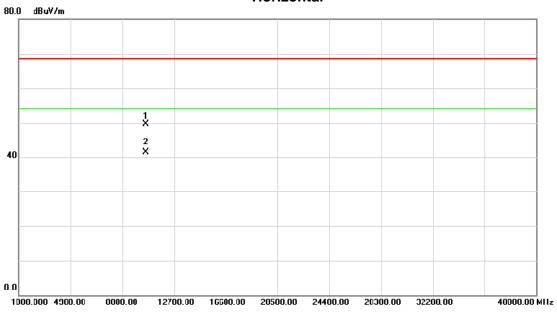
No	Mk	Freq	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MI Iz	dDu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	5259.000	49.49	42.43	91.92	54.00	37.92	AVG	Fundamental frequency, no limit
2	X	5261 000	57 23	42 45	99 68	68 30	31 38	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 106 of 215



Test Mode: Band 2/ TX N20 Mode 5260MHz

Horizontal



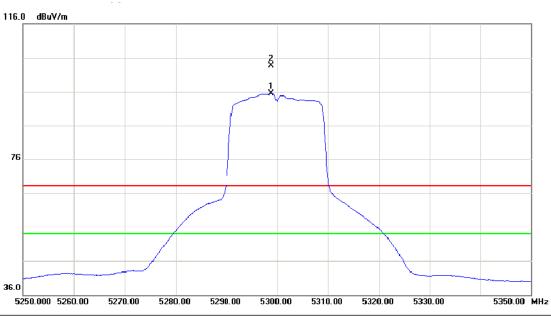
No.	Mk	. Froq.			Measure- ment		Over		
		MI IZ	dBu∀	dΒ	dBuV/m	dBu∀/m	dB	Detector	Comment
1		10520.50	33.91	15.88	49.79	68.30	-18.51	peak	
2	*	10520.50	25.47	15.88	41.35	54.00	-12.65	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 107 of 215



Test Mode: Band 2/ TX A Mode 5300MHz

Vertical



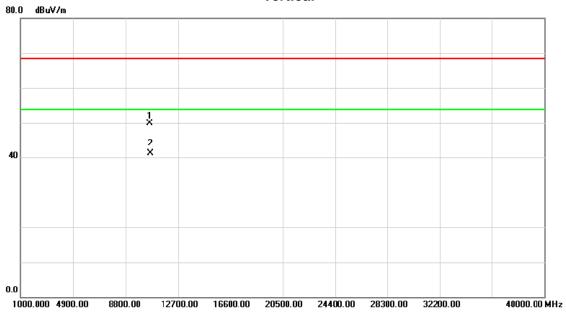
No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	X	5298.800	52.98	42.60	95.58	68.30	27.28	peak	Fundamental frequency, no limit
2	*	5298.930	61.20	42.60	103.80	68.30	35.50	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 108 of 215



Test Mode: Band 2/ TX A Mode 5300MHz

Vertical



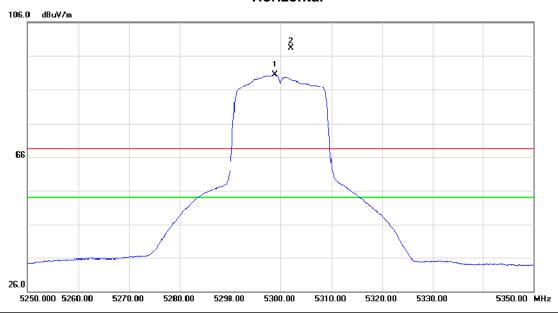
No.	Mk	. Freq.	_		Measure- ment	Limit	Over		
		MHz	dBu∨	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		10600.30	33.79	16.11	49.90	68.30	-18.40	peak	
2	*	10600.30	24.94	16.11	41.05	54.00	-12.95	AVG	

Report No.: NEI-FCCP-1-1406C191 Page 109 of 215



Test Mode: Band 2/ TX A Mode 5300MHz

Horizontal



N	lo.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
	1	*	5298.800	47.84	42.60	90.44	54.00	36.44	AVG	Fundamental frequency, no limit
	2	X	5302.000	55.67	42.61	98.28	68.30	29.98	peak	Fundamental frequency, no limit

Report No.: NEI-FCCP-1-1406C191 Page 110 of 215